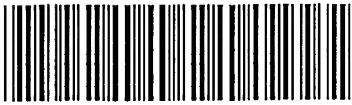


**Search Notes**

Application/Control No.

10/660,698

Examiner

Fikremariam Yalew

Applicant(s)/Patent under  
Reexamination

OHISHI ET AL.

Art Unit

2136

**SEARCHED**

Class	Subclass	Date	Examiner
380	200	3/30/2007	FA
713	182	3/30/2007	FA

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East(classification search and text search)	3/30/2007	FA
IEEE	3/30/2007	FA
Inventor search	3/30/2007	FA